

### FEATURES

- Double Side Cooling
- High Surge Capability

### APPLICATIONS

- High Power Drives
- High Voltage Power Supplies
- Static Switches

### VOLTAGE RATINGS

Part and Ordering Number	Repetitive Peak Voltages $V_{DRM}$ and $V_{RRM}$ V	Conditions
DCR1180F52	5200	$T_{vj} = -40^{\circ}\text{C to } 125^{\circ}\text{C}$ , $I_{DRM} = I_{RRM} = 150\text{mA}$ , $V_{DRM}, V_{RRM} t_p = 10\text{ms}$ , $V_{DSM} \& V_{RSM} =$ $V_{DRM} \& V_{RRM} + 100\text{V}$ respectively
DCR1180F50	5000	
DCR1180F48	4800	

Lower voltage grades available.

### ORDERING INFORMATION

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

#### DCR1180F52

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

### KEY PARAMETERS

$V_{DRM}$	<b>5200V</b>
$I_{T(AV)}$	<b>1180A</b>
$I_{TSM}$	<b>15900A</b>
$dV/dt^*$	<b>1500V/<math>\mu\text{s}</math></b>
$dI/dt$	<b>300A/<math>\mu\text{s}</math></b>

\* Higher  $dV/dt$  selections available

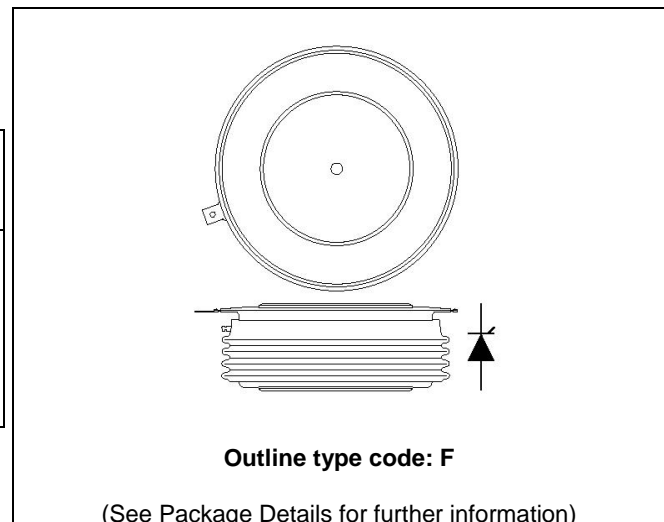


Fig. 1 Package outline

## CURRENT RATINGS

$T_{case} = 60^{\circ}C$  unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
<b>Double Side Cooled</b>				
$I_{T(AV)}$	Mean on-state current	Half wave resistive load	1180	A
$I_{T(RMS)}$	RMS value	-	1854	A
$I_T$	Continuous (direct) on-state current	-	1812	A

## SURGE RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
$I_{TSM}$	Surge (non-repetitive) on-state current	10ms half sine, $T_{case} = 125^{\circ}C$	15.9	kA
$I^2t$	$I^2t$ for fusing	$V_R = 0$	1.26	MA <sup>2</sup> s

## THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions	Min.	Max.	Units	
$R_{th(j-c)}$	Thermal resistance – junction to case	Double side cooled	DC	-	0.0171	$^{\circ}C/W$
		Single side cooled	Anode DC	-	0.0313	$^{\circ}C/W$
			Cathode DC	-	0.0378	$^{\circ}C/W$
$R_{th(c-h)}$	Thermal resistance – case to heatsink	Clamping force 23kN (with mounting compound)	Double side	-	0.004	$^{\circ}C/W$
			Single side	-	0.008	$^{\circ}C/W$
$T_{vj}$	Virtual junction temperature	On-state (conducting)	-	135	$^{\circ}C$	
		Reverse (blocking)	-	125	$^{\circ}C$	
$T_{stg}$	Storage temperature range		-55	125	$^{\circ}C$	
$F_m$	Clamping force		22.0	25.0	kN	

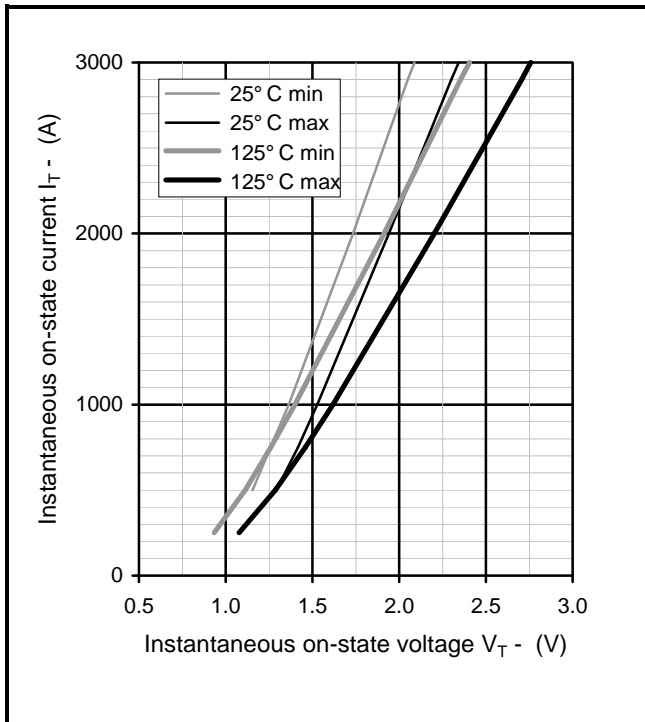
**DYNAMIC CHARACTERISTICS**

Symbol	Parameter	Test Conditions	Min.	Max.	Units	
$I_{RRM}/I_{DRM}$	Peak reverse and off-state current	At $V_{RRM}/V_{DRM}$ , $T_{case} = 125^{\circ}C$	-	150	mA	
$dV/dt$	Max. linear rate of rise of off-state voltage	To 67% $V_{DRM}$ , $T_j = 125^{\circ}C$ , gate open	-	1500	V/ $\mu s$	
$di/dt$	Rate of rise of on-state current	From 67% $V_{DRM}$ to $2x I_{T(AV)}$	Repetitive 50Hz	-	150	A/ $\mu s$
		Gate source 30V, 10 $\Omega$ , $t_r < 0.5\mu s$ , $T_j = 125^{\circ}C$	Non-repetitive	-	300	A/ $\mu s$
$V_{T(TO)}$	Threshold voltage – Low level	100A to 800A at $T_{case} = 125^{\circ}C$	-	0.9	V	
	Threshold voltage – High level	800A to 3000A at $T_{case} = 125^{\circ}C$	-	1.05	V	
$r_T$	On-state slope resistance – Low level	100A to 800A at $T_{case} = 125^{\circ}C$	-	0.750	m $\Omega$	
	On-state slope resistance – High level	800A to 3000A at $T_{case} = 125^{\circ}C$	-	0.567	m $\Omega$	
$t_{gd}$	Delay time	$V_D = 67\% V_{DRM}$ , gate source 30V, 10 $\Omega$ $t_r = 0.5\mu s$ , $T_j = 25^{\circ}C$	TBD	TBD	$\mu s$	
$t_q$	Turn-off time	$T_j = 125^{\circ}C$ , $V_R = 200V$ , $di/dt = 1A/\mu s$ , $dV_{DR}/dt = 20V/\mu s$ linear	400	800	$\mu s$	
$Q_S$	Stored charge	$I_T = 2000A$ , $T_j = 125^{\circ}C$ , $di/dt = 1A/\mu s$ ,	1200	2750	$\mu C$	
$I_L$	Latching current	$T_j = 25^{\circ}C$ , $V_B = 5V$	TBD	TBD	mA	
$I_H$	Holding current	$T_j = 25^{\circ}C$ , $R_{G-K} = \infty$ , $I_{TM} = 500A$ , $I_T = 5A$	TBD	TBD	mA	

**GATE TRIGGER CHARACTERISTICS AND RATINGS**

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>GT</sub>	Gate trigger voltage	V <sub>DRM</sub> = 5V, T <sub>case</sub> = 25° C	1.5	V
V <sub>GD</sub>	Gate non-trigger voltage	At V <sub>DRM</sub> , T <sub>case</sub> = 125° C	TBD	V
I <sub>GT</sub>	Gate trigger current	V <sub>DRM</sub> = 5V, T <sub>case</sub> = 25° C	250	mA
I <sub>GD</sub>	Gate non-trigger current	V <sub>DRM</sub> = 5V, T <sub>case</sub> = 25° C	TBD	mA

**CURVES**



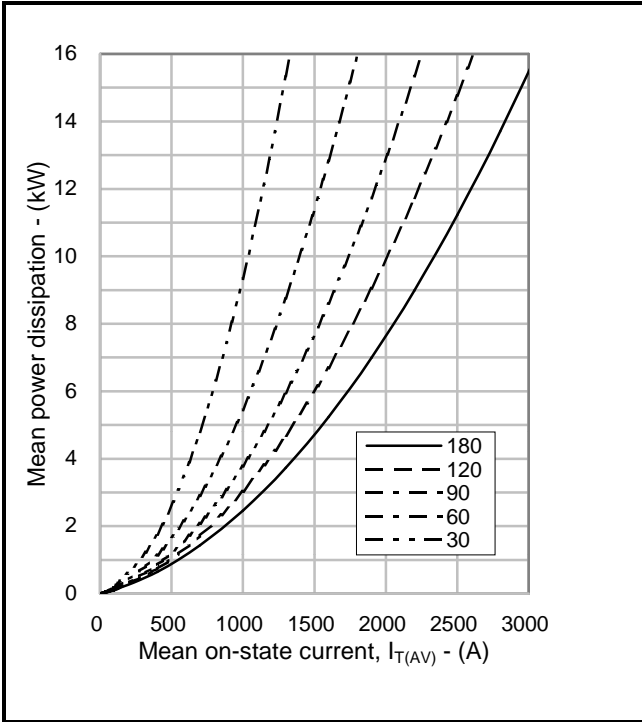
**Fig.2 Maximum & minimum on-state characteristics**

**V<sub>TM</sub> EQUATION**

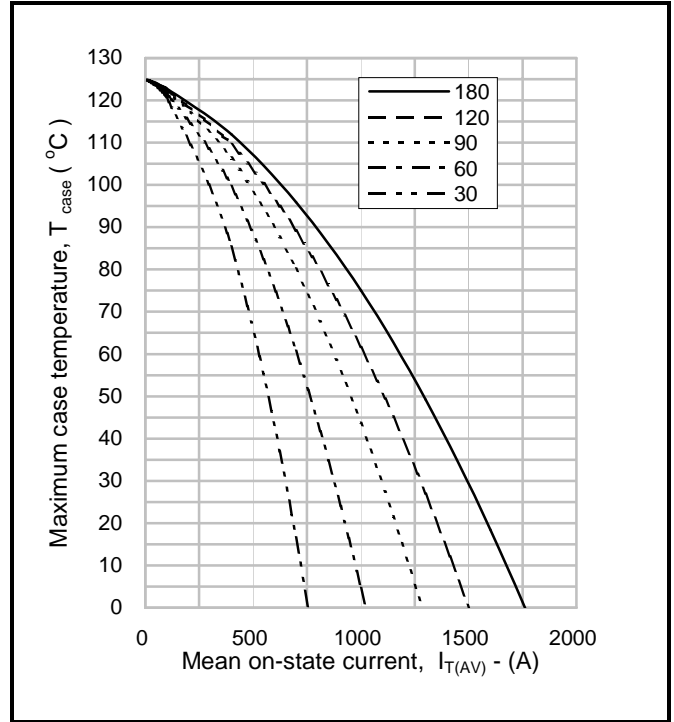
$$V_{TM} = A + B \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

Where A = 0.102312  
 B = 0.174461  
 C = 0.000567  
 D = -0.008061

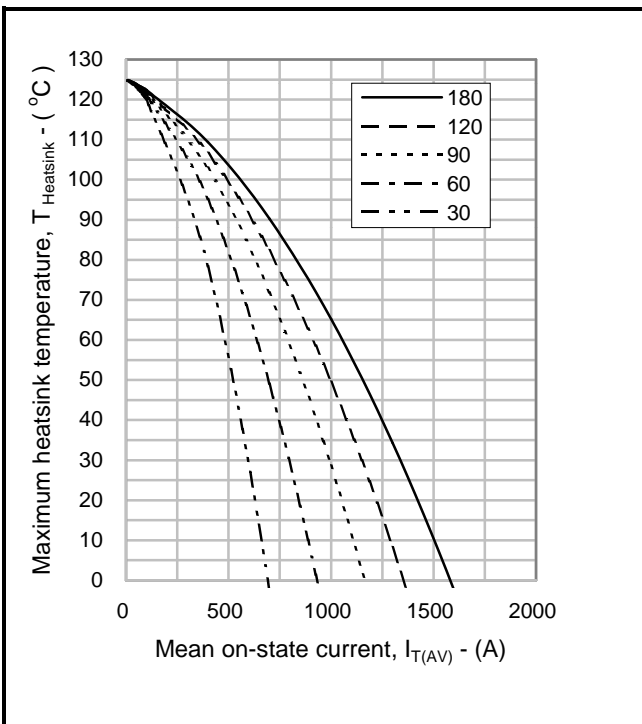
these values are valid for T<sub>j</sub> = 125° C for I<sub>T</sub> 100A to 3000A



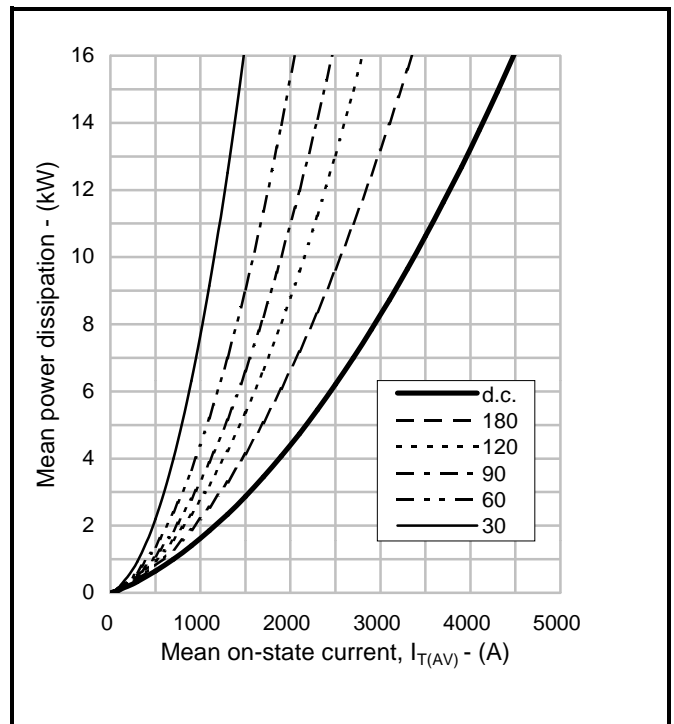
**Fig.3 On-state power dissipation – sine wave**



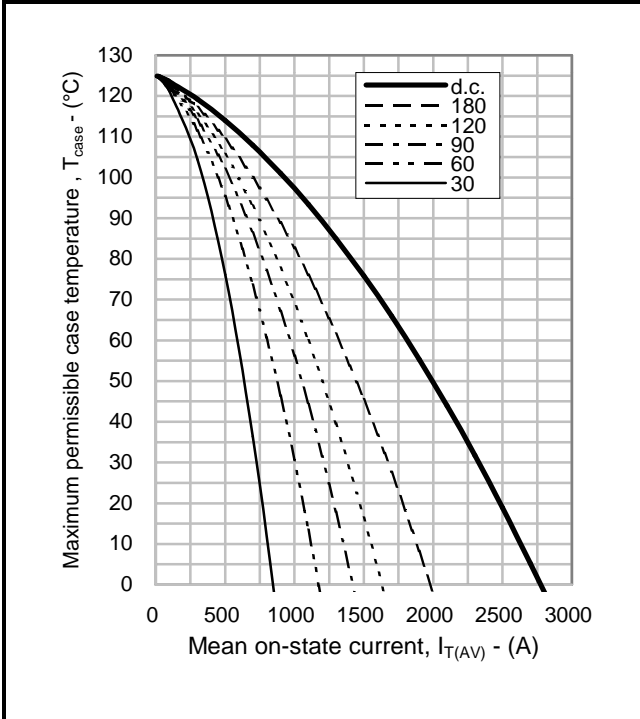
**Fig.4 Maximum permissible case temperature, double side cooled – sine wave**



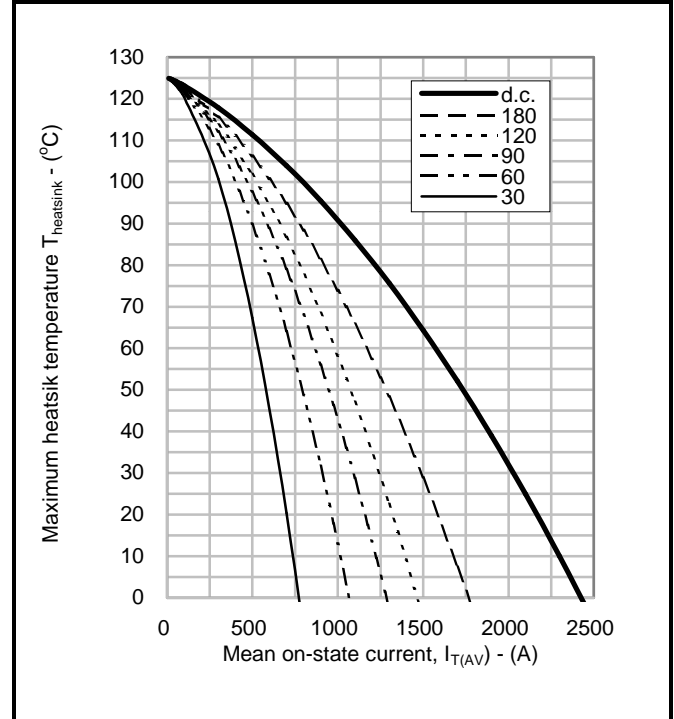
**Fig.5 Maximum permissible heatsink temperature, double side cooled – sine wave**



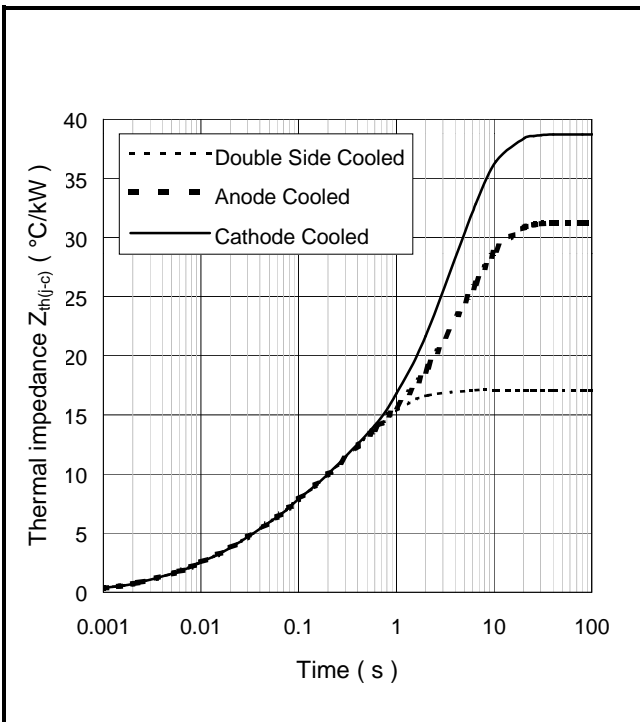
**Fig.6 On-state power dissipation – rectangular wave**



**Fig.7 Maximum permissible case temperature, double side cooled – rectangular wave**



**Fig.8 Maximum permissible heatsink temperature, double side cooled – rectangular wave**



**Fig.9 Maximum (limit) transient thermal impedance – junction to case (° C/kW)**

		1	2	3	4
Double side cooled	R <sub>i</sub> (°C/kW)	2.0345	4.8026	8.8692	1.3748
	T <sub>i</sub> (s)	0.0072774	0.0546296	0.4673207	1.5324
Anode side cooled	R <sub>i</sub> (°C/kW)	2.0227	4.5436	6.0443	18.6113
	T <sub>i</sub> (s)	0.0072364	0.0524941	0.320548	5.0367
Cathode side cooled	R <sub>i</sub> (°C/kW)	2.104	5.1949	4.0364	27.3362
	T <sub>i</sub> (s)	0.007431	0.0594595	0.3929454	4.2034

$$Z_{th} = \sum [R_i \times (1 - \exp. -(t/t_i))] \quad [1]$$

$\Delta R_{th(j-c)}$  Conduction

Tables show the increments of thermal resistance  $R_{th(j-c)}$  when the device operates at conduction angles other than d.c.

Double side cooling			Anode Side Cooling			Cathode Sided Cooling		
$\theta_c^\circ$	$\Delta Z_{th} (z)$		$\theta_c^\circ$	$\Delta Z_{th} (z)$		$\theta_c^\circ$	$\Delta Z_{th} (z)$	
	sine.	rect.		sine.	rect.		sine.	rect.
180	3.22	2.12	180	3.23	2.12	180	3.22	2.12
120	3.79	3.12	120	3.80	3.13	120	3.79	3.12
90	4.43	3.71	90	4.44	3.72	90	4.42	3.71
60	5.02	4.36	60	5.04	4.38	60	5.02	4.36
30	5.50	5.10	30	5.52	5.12	30	5.49	5.10
15	5.72	5.51	15	5.74	5.53	15	5.71	5.50

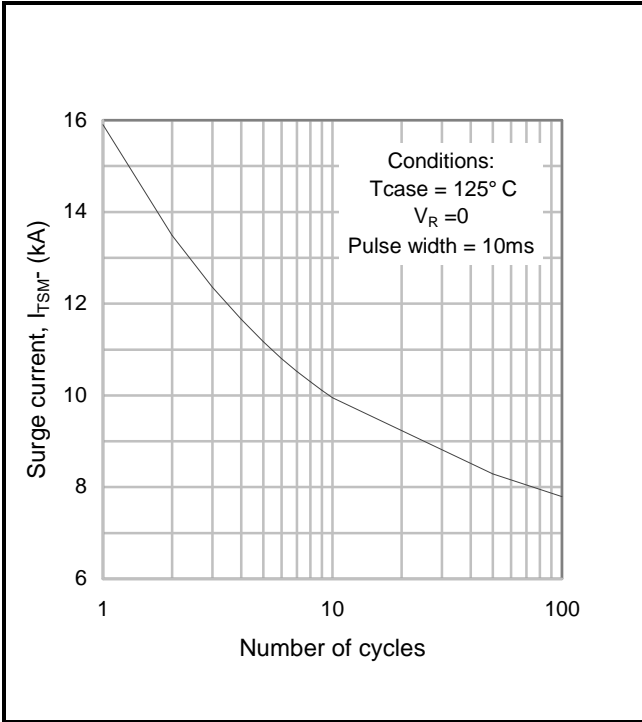


Fig.10 Multi-cycle surge current

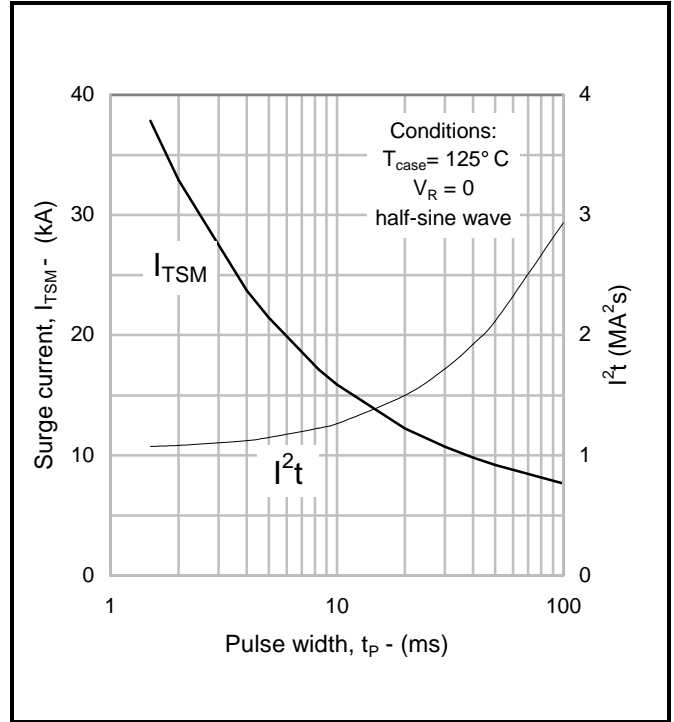
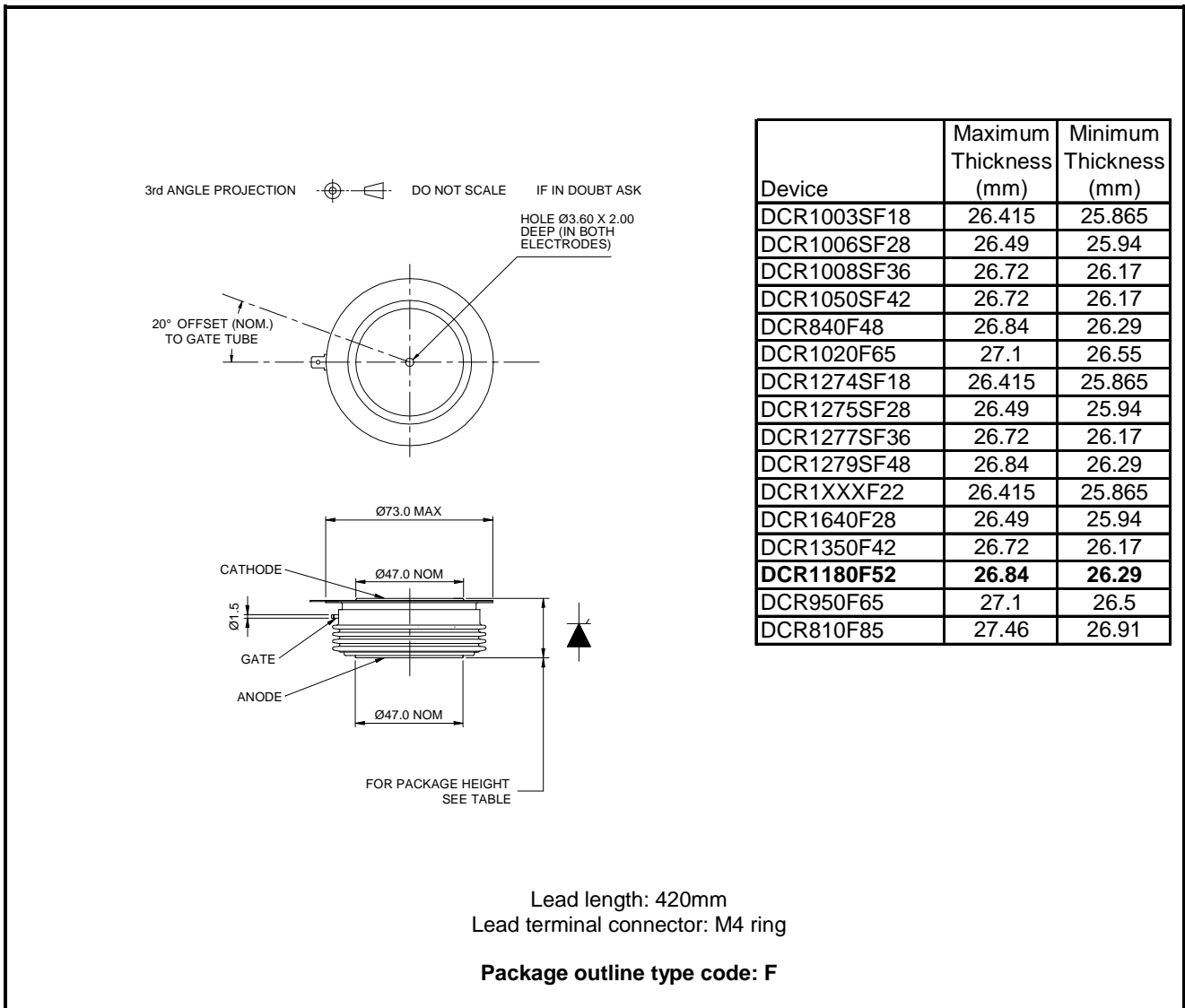


Fig.11 Single-cycle surge current

**PACKAGE DETAILS**

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.**



**Fig.15 Package outline**



## **POWER ASSEMBLY CAPABILITY**

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

## **HEATSINKS**

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.

Stresses above those listed in this data sheet may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed.



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